Small Signal MOSFET

Single N-Channel, 60 V, 380 mA, 1.6 Ohm, SOT-23

Features

- ESD Protected
- Low R_{DS(on)}
- Surface Mount Package
- 2V Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Low Side Load Switch
- Level Shift Circuits
- DC-DC Converter
- Portable Applications i.e. DSC, PDA, Cell Phone, etc.

MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

D .:			1114	
Rating	Symbol	Value	Unit	
Drain-to-Source Voltage	V _{DSS}	60	V	
Gate-to-Source Voltage	V_{GS}	±20	V	
$ \begin{array}{l} \mbox{Drain Current (Note 1)} \\ \mbox{Steady State 1 sq in Pad} \\ \mbox{T}_{A} = 25^{\circ}\mbox{C} \\ \mbox{T}_{A} = 85^{\circ}\mbox{C} \end{array} $	Ι _D	380 270	mA	
$ \begin{array}{ c c c } \hline \text{Drain Current (Note 2)} \\ \text{Steady State Minimum Pad} & $T_A = 25^\circ C$ \\ $T_A = 85^\circ C$ \\ \hline \end{array} $	۱ _D	320 230	mA	
Power Dissipation Steady State 1 sq in Pad Steady State Minimum Pad	P _D	420 300	mW	
Pulsed Drain Current ($t_p = 10 \ \mu s$)	I _{DM}	5.0	А	
Operating Junction and Storage Temperature Range	T _J , T _{STG}	–55 to +150	°C	
Source Current (Body Diode)	I _S	300	mA	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	ΤL	260	°C	
Gate-Source ESD Rating (HBM, Method 3015)	ESD	2000	V	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Surface-mounted on FR4 board using 1 sq in pad size with 1 oz Cu.
- 2. Surface-mounted on FR4 board using 0.08 sq in pad size with 1 oz Cu.

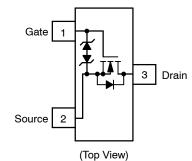


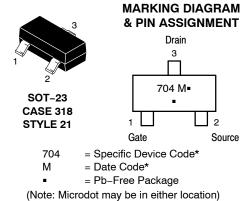
ON Semiconductor®

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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX		
60 V	1.6 Ω @ 10 V	380 mA		
00 V	2.5 Ω @ 4.5 V	360 MA		

SIMPLIFIED SCHEMATIC





(Note: Microdot may be in either location) *Specific Device Code, Date Code or overbar orientation and/or location may vary depending upon manufacturing location. This is a representation only and actual devices may not match this drawing exactly.

ORDERING INFORMATION

Device	Package	Shipping [†]		
2N7002KT1G, 2V7002KT1G	SOT-23 (Pb-Free)	3000 / Tape & Reel		
2N7002KT7G	SOT-23 (Pb-Free)	3500 / Tape & Reel		

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Мах	Unit
Junction-to-Ambient - Steady State (Note 3)	$R_{ extsf{ heta}JA}$	300	°C/W
Junction-to-Ambient – t \leq 5 s (Note 3)		92	
Junction-to-Ambient - Steady State (Note 4)		417	
Junction-to-Ambient – t \leq 5 s (Note 4)		154	

Surface-mounted on FR4 board using 1 sq in pad size with 1 oz Cu.
Surface-mounted on FR4 board using 0.08 sq in pad size with 1 oz Cu.

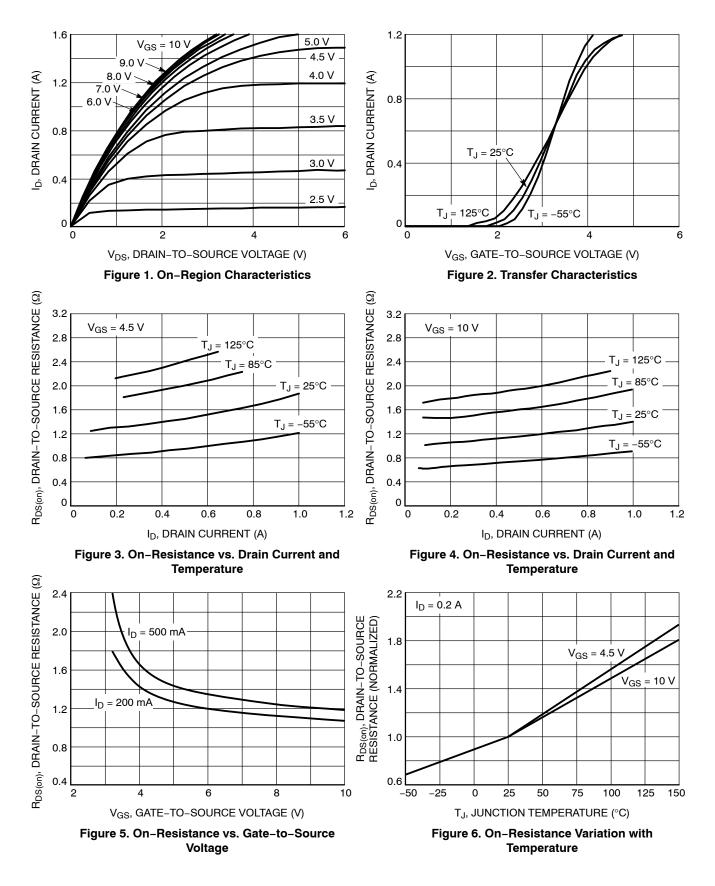
ELECTRICAL CHARACTERISTICS (T,I = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS		•					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				71		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1	μA
		V _{DS} = 60 V	T _J = 125°C			10	
		V _{GS} = 0 V, V _{DS} = 50 V	T _J = 25°C			100	nA
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V	V _{GS} = ±20 V			±10	μA
		V _{DS} = 0 V, V	V _{GS} = ±10 V			450	nA
		V _{DS} = 0 V, \	/ _{GS} = ±5.0 V			150	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, I _D = 250 μA	1.0		2.3	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V,	I _D = 500 mA		1.19	1.6	Ω
		V_{GS} = 4.5 V, I _D = 200 mA			1.33	2.5	
Forward Transconductance	9 FS	$V_{DS} = 5 \text{ V}, \text{ I}_{D} = 200 \text{ mA}$			530		mS
CHARGES AND CAPACITANCES							_
Input Capacitance	C _{ISS}	$V_{GS} = 0 V, f = 1 MHz,$			24.5	45	pF
Output Capacitance	C _{OSS}				4.2	8.0	
Reverse Transfer Capacitance	C _{RSS}	VDS -	V _{DS} = 20 V		2.2	5.0	
Total Gate Charge	Q _{G(TOT)}				0.7		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V	′, V _{DS} = 10 V;		0.1		
Gate-to-Source Charge	Q _{GS}	$I_{\rm D} = 200 {\rm mA}$			0.3		
Gate-to-Drain Charge	Q _{GD}				0.1		
SWITCHING CHARACTERISTICS, V _{GS}	= V (Note 6)						
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DD} = 25 V, I _D = 500 mA, R _G = 25 Ω			12.2		ns
Rise Time	t _r				9.0		
Turn-Off Delay Time	t _{d(OFF)}				55.8		
Fall Time	t _f				29		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.8	1.2	V
		I _S = 200 mA	T _J = 85°C		0.7]

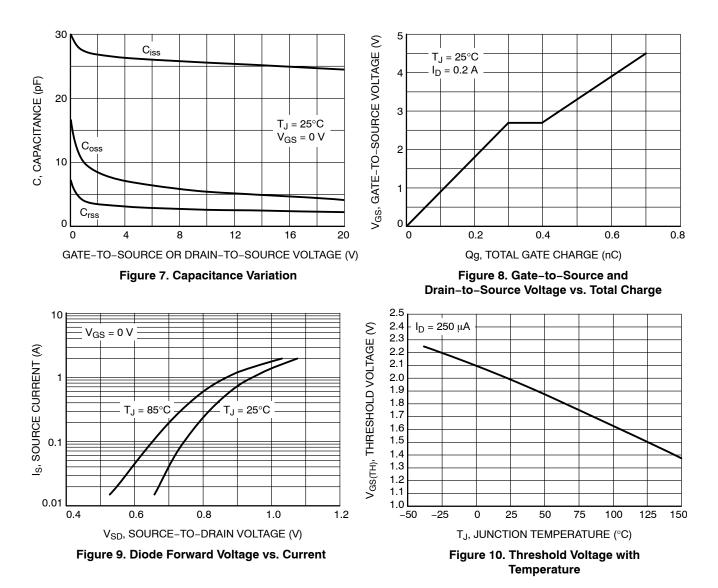
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%

6. Switching characteristics are independent of operating junction temperatures

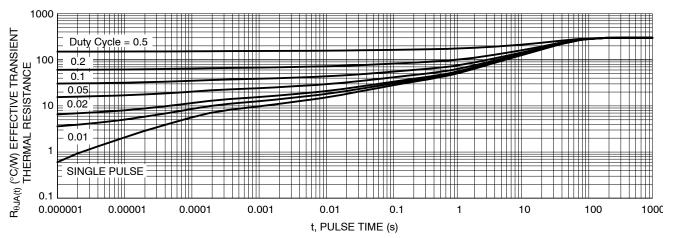
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS





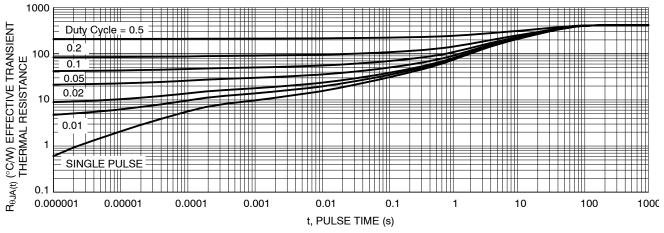


Figure 12. Thermal Response – minimum pad





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